PTO/SB/08A (10-01)
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2877

Substitute for form 1449A/PTO Complete if Known Application No. 10/782,267 INFORMATION DISCLOSURE Filing Date February 18, 2004 STATEMENT BY APPLICANT First Named Inventor Steven W. Meeks Art Unit

**Examiner Name** Not Yet Known Attorney Docket Number Sheet of 4 20830-08855

			U.S. PATE	NT DOCUMENTS
		Document No.		
Examiner Initials*	Cite No.1.	Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
TN	A1	3,885,875	05/27/1975	Rosenfeld et al.
1	A2	4,332,477	06/01/1982	Sato
	A3	4,585,348	04/29/1986	Chastang et al.
	A4	4,668,860	05/26/1987	Anthon
	A5	4,870,631	09/26/1989	Stoddard
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	A8	5,129,724	07/14/1992	Brophy et al.
	A9	5,189,481	02/23/1993	Jann et al.
	A10	5,196,906	03/23/1993	Stover et al.
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	A13	5,313,542	05/17/1994	Castonguay
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	A15	5,416,594	05/16/1995	Gross et al.
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	A22	5,694,214	12/02/1997	Watanabe et al.
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	A24	5,748,305	05/05/1998	Shimono et al.
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Τ,	A29	5,880,838	03/09/1999	Marx et al.
12	A30	5,903,342	05/11/1999	Yatsugake et al.

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	Substitute for	form 1449/	VPTO .	Complete if Known			
INEC		I DIS	CLOSURE	Application No.	10/782,267		
•			PLICANT	Filing Date	February 18, 2004		
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•				Art Unit	2877		
				Examiner Name	Not Yet Known		
Sheet	· 2	of	4	Attorney Docket Number	20830-08855		

			U.S. PATE	NT DOCUMENTS
		Document No.		
Examiner Initials*	Cite No.	Number - Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
TN	A31	5,951,891	09/14/1999	Barenboim et al.
	A32	5,978,091	11/02/1999	Jann et al.
	A33	5,985,680	11/16/1999	Singhal et al.
	A34	5,986,761	11/16/1999	Crawforth et al.
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	A37	6,081,325	06/27/2000	Leslie et al.
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	A40	6,107,637	08/22/2000	Watanabe et al.
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Ta	A54	6,603,542	08/202003	Chase et al.
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		Substitute for	form 1449.	VPTO	Complete if Known			
	NEOE	DITARE	פוח וא	CLOSURE	Application No.	10/782,267		
•				PLICANT	Filing Date	February 18, 2004		
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					Art Unit	2877		
					Examiner Name	Not Yet Known		
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			U.S. PATE	NT DOCUMENTS	
		Document No.			
Examiner Initials*	Cite No.1	Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	
•			FOREIGN PA	TENT DOCUMENTS	
		Foreign Patent Document			
Examiner Initials*	Cite No. <sup>1</sup>	Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD- YYYY.	Name of Patentee or Applicant of Cited Document	T <sup>6</sup>
TN	B1	WO 98/52019	11/19/1998	Technische Universiteit Delft	
TN	B2	JP 3-221804	09/30/1991	NEC Corp	

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	Substitute for fo	orm 1449	VPTO .		Complete if Known	
INEC		ו חופי	CLOSURE	Application No.	10/782,267	
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,				Art Unit	2877	
				Examiner Name	Not Yet Known	
Sheet	· 4	of	4	Attorney Docket Number	20830-08855	

		OTHER REFERENCES - NON-PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>6</sup>
Ta	C1	W.C. Leung, W. Crooks, H. Rosen and T. Strand, An Optical Method Using a Laser and an Integrating Sphere Combination for Characterizing the Thickness Profile of Magnetic Media, Sept. 1989, IEEE Transaction on Magnetics, Vol. 25, No. 5. Pages 3659-3661.	
	C2	Steven W. Meeks, Walter E. Weresin, and Hal J. Rosen, <i>Optical Surface Analysis of the Head-Disk-Interface of Thin Film Disks</i> , January 1995, Transactions of the ASME, Journal of Tribology, Vol. 117, pages 112-118.	
	C3	Steven Meeks, Maxtor and Rusmin Kudinar, <i>The Next Battleground: Head-Disk Interface</i> , March 1998, Data Storage, Test & Measurement, pages 29-30, 34 and 38.	
	C4	Laser Scanning Surface Profilometer, [online], August 1970, [retrieved January 29, 2001], Pages 789-790, Retrieved from the Internet: <url: http:="" tdb?&order="7OC101758.&lt;/td" tdbs="" www.delphion.com=""><td></td></url:>	
7~	C5 	Meeks, Steven W.: "A Combined Ellipsometer, Reflectometer, Scatterometer and Kerr Effect Microscope for Thin Film Disk Characterization," Machine Vision Applications in Industrial Inspection VIII, Proceedings of SPIE, vol. 3966, 2000, pages 385-391, XP001085220.	

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PANFOAD Substitute for form 1449A/PTO Complete if Known Application No. 10/782,267 INFORMATION DISCLOSURE Filing Date February 18, 2004 STATEMENT BY APPLICANT **First Named Inventor** Steven W. Meeks Art Unit 2877 **Examiner Name** Tu T. Nguyen Attorney Docket Number Sheet of 20830-08855

			U.S. PATE	ENT DOCUMENTS
		Document No.	1	
Examiner Initials*	Cite No.1	Number – Kind Code² (if known)	Date MM-YYYY	Name of Patentee or Applicant of Cited Document
TW	A1	US-6,639,662	10-2003	Vaez-Iravani et al.
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-		Foreign Patent Document					
Examiner Initials*	Cite No. <sup>1</sup>	Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Τ⁵		

OTHER REFERENCES - NON-PATENT LITERATURE DOCUMENTS							
Examiner Initials*	Cite Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published						
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